

<b>Notice of References Cited</b>	Application/Control No. 10/517,617	Applicant(s)/Patent Under Reexamination SUENAGA ET AL.	
	Examiner Nguyen T. Ha	Art Unit 2831	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,556,427	04-2003	Ohata et al.	361/528
*	C	US-6,426,866	07-2002	Shoji et al.	361/523
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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